

SN74AC07-Q1 Automotive Hex Buffers with Open-Drain Outputs

1 Features

- AEC-Q100 qualified for automotive applications:
 - Device temperature grade 1: -40°C to +125°C
 - Device HBM ESD classification level 2
 - Device CDM ESD classification level C4B
- Available in wettable flank QFN package
- Wide operating range of 1.5V to 6V
- Inputs accept voltages up to 6V
- Continuous 24mA output drive at 5V
- Supports up to 75mA output drive at 5V in short bursts
- Drives 50Ω transmission lines
- Maximum t_{pd} of 6.6ns at 5V, 50pF load

2 Applications

- Drive an indicator LED
- Level-shift using open-drain outputs
- Control a relay

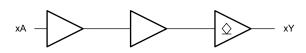
3 Description

The SN74AC07-Q1 device contains six independent CMOS logic buffers with open-drain outputs.

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾	BODY SIZE ⁽³⁾	
SN74AC07-Q1	BQA (WQFN, 14) 3mm × 2		3mm × 2.5mm	
3N/4AC07-Q1	PW (TSSOP, 14)	5mm × 6.4mm	5mm × 4.4mm	

- (1) For more information, see Section 11.
- (2) The package size (length × width) is a nominal value and includes pins, where applicable.
- (3) The body size (length × width) is a nominal value and does not include pins.



Functional Diagram



Table of Contents

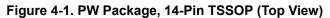
1	Features	.1
2	Applications	1
	Description	
4	Pin Configuration and Functions	3
5	Specifications	4
	5.1 Absolute Maximum Ratings	4
	5.2 ESD Ratings	4
	5.3 Recommended Operating Conditions	4
	5.4 Thermal Information	5
	5.5 Electrical Characteristics	5
	5.6 Switching Characteristics	5
	5.7 Typical Characteristics	6
6	Parameter Measurement Information	
7	Detailed Description	9
	7.1 Description	9
	7.2 Functional Block Diagram	9
	7.3 Feature Description	

7.4 Device Functional Modes	11
8 Application and Implementation	12
8.1 Application Information	12
8.2 Typical Application	
8.3 Power Supply Recommendations	15
8.4 Layout	15
9 Device and Documentation Support	
9.1 Documentation Support	17
9.2 Receiving Notification of Documentation Update	s <mark>17</mark>
9.3 Support Resources	17
9.4 Trademarks	17
9.5 Electrostatic Discharge Caution	17
9.6 Glossary	17
10 Revision History	
11 Mechanical, Packaging, and Orderable	
Information	17



4 Pin Configuration and Functions

			1
1A 🗆	1	14	
1Y 🗖	2	13	🖵 6A
2A 🗆	3	12	6Y
2Y 🗖	4	11	🖵 5A
3A 🗆	5	10	
3Y 🗖	6	9	4A
GND	7	8	□ 4Y



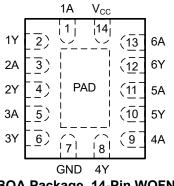


Figure 4-2. BQA Package, 14-Pin WQFN (Top View)

PIN		- I/O	DESCRIPTION			
NAME	NO.	- 1/0	DESCRIPTION			
1A	1	Input	Channel 1, Input A			
1Y	2	Output	Channel 1, Output Y			
2A	3	Input	annel 2, Input A			
2Y	4	Output	Channel 2, Output Y			
3A	5	Input	Channel 3, Input A			
3Y	6	Output	Channel 3, Output Y			
GND	7		Ground			
4Y	8	Output	Channel 4, Output Y			
4A	9	Input	Channel 4, Input A			
5Y	10	Output	Channel 5, Output Y			
5A	11	Input	Channel 5, Input A			
6Y	12	Output	Channel 6, Output Y			
6A	13	Input	Channel 6, Input A			
V _{CC}	14	_	Positive Supply			
Thermal Pac	j (1)	_	The thermal pad can be connected to GND or left floating. Do not connect to any other signal or supply			

Table 4-1. Pin Functions

(1) BQA package only.

5 Specifications

SN74AC07-Q1

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Supply voltage range		-0.5	7	V
Input voltage range ⁽²⁾		-0.5	V _{CC} + 0.5V	V
Output voltage range ⁽²⁾		-0.5	7	V
Input clamp current	$V_1 < -0.5V \text{ or } V_1 > V_{CC} + 0.5V$		±20	mA
Output clamp current	V _O < -0.5V		-50	mA
Continuous output current	V _O = 0 to 6V		50	mA
Continuous output current through V_{CC} or GND			±200	mA
Storage temperature		-65	150	°C
Junction temperature			150	°C
	Input voltage range ⁽²⁾ Output voltage range ⁽²⁾ Input clamp current Output clamp current Continuous output current Continuous output current through V _{CC} or GND Storage temperature	Input voltage range ⁽²⁾ Input voltage range ⁽²⁾ Output voltage range ⁽²⁾ V1 < -0.5V or V1 > V2 Input clamp current V1 < -0.5V or V1 > V2 Output clamp current V0 < -0.5V	Supply voltage range-0.5Input voltage range(2)-0.5Output voltage range(2)-0.5Input clamp current $V_1 < -0.5V$ or $V_1 > V_{CC} + 0.5V$ Output clamp current $V_0 < -0.5V$ Continuous output current $V_0 < -0.5V$ Continuous output current through V_{CC} or GND-0.5Storage temperature-0.5	Supply voltage range-0.57Input voltage range(2)-0.5 $V_{CC} + 0.5V$ Output voltage range(2)-0.5 7 Input clamp current $V_1 < -0.5V$ or $V_1 > V_{CC} + 0.5V$ ± 20 Output clamp current $V_0 < -0.5V$ ± 20 Continuous output current $V_0 < -0.5V$ 50 Continuous output current through V_{CC} or GND ± 200 ± 200 Storage temperature -65 150

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If briefly operating outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.

(2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

5.2 ESD Ratings

				VALUE	UNIT	
Electrostatic		Electrostatic	Human body model (HBM), per AEC Q100-002 HBM ESD Classification Level $2^{(1)}$	±2000		
	V _(ESD)		Charged device model (CDM), per AEC Q100-011 CDM ESD Classification Level C4B	±1000	V	

(1) AEC Q100-002 indicate that HBM stressing shall be in accordrance with the ANSI/ESDA/JEDEC JS-001 specification.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

Spec	Description	Condition	MIN	MAX	UNIT
V _{CC}	Supply voltage		1.5	6	V
		V _{CC} = 1.5V	1.2		V
		V _{CC} = 1.8V	1.26		V
N/	Llich lovel input veltage	V _{CC} = 2.5V	1.75		V
V _{IH}	High-level input voltage	V _{CC} = 3V	2.1		V
		V _{CC} = 4.5V	3.15		V
		V _{CC} = 5.5V	3.85		V
	Low-Level input voltage	V _{CC} = 1.5V		0.3	V
		V _{CC} = 1.8V		0.54	V
N7		V _{CC} = 2.5V		0.75	
V _{IL}		V _{CC} = 3V		0.9	V
		V _{CC} = 4.5V		1.35	V
		V _{CC} = 5.5V		1.65	V
VI	Input Voltage		0	V _{CC}	V
Vo	Output Voltage		0	6	V

over operating free-air temperature range (unless otherwise noted)

Spec	Description	Condition	MIN	MAX	UNIT
		V _{CC} = 1.8V		1	mA
	Low-level output current	V _{CC} = 2.5V		2	mA
IOL		V _{CC} = 3V		12	mA
		V _{CC} = 4.5 to 5.5V		24	mA
Δt/Δv		V _{CC} = 1.5 to 3V		50	ns/V
	Input transition rise or fall rate	V _{CC} > 3V		20	ns/V
T _A	Operating free-air temperature		-40	125	°C

5.4 Thermal Information

PACKAGE	PINS	THERMAL METRIC ⁽¹⁾					UNIT	
PACKAGE	PINS	R _{0JA}	R _{0JC(top)}	R _{0JB}	Ψ_{JT}	Ψ_{JB}	R _{0JC(bot)}	UNIT
PW (TSSOP)	14	132.2	64.8	88.4	11.9	87.4	N/A	°C/W
BQA (WQFN)	14	85.4	89.0	54.8	9.1	54.7	31.4	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application note.

5.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

		N	-40°0	C to 125°C		
PARAMETER	TEST CONDITIONS	V _{cc}	MIN	TYP	MAX	UNIT
		1.5V		0.001	0.1	
		1.8V		0.001	0.1	
		2.5V		0.001	0.1	
	Ι _{ΟL} = 50μΑ	3V		0.001	0.1	
		4.5V		0.001	0.1	
		5.5V		0.001	0.1	
V _{OL}	I _{OL} = 1mA	1.8V			0.36	V
	I _{OL} = 2mA	2.5V			0.5	
	I _{OL} = 4mA	3V			0.5	
	I _{OL} = 12mA	3V			0.5	
	I _{OL} = 24mA	4.5V			0.5	
	I _{OL} = 24mA	5.5V			0.5	
	I _{OL} = 75mA ⁽¹⁾	5.5V			1.65	
I _I	V _I = 5.5V or GND	0 to 5.5V			±1	μA
I _{CC}	$V_{I} = V_{CC}$ or GND, $I_{O} = 0$	5.5V			2	μA
CI	V _I = V _{CC} or GND	5V		2		pF
Co	$V_{O} = V_{CC}$ or GND	5V		3		pF
C _{PD}	C _L = 50pF, F = 1MHz	5V		12		pF

(1) Duration not to exceed 2ms

5.6 Switching Characteristics

 C_L = 50 pF; over operating free-air temperature range; typical values measured at T_A = 25°C (unless otherwise noted). See *Parameter Measurement Information*.

	PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{cc}	-40°C to 125°C			UNIT
	PARAMETER				MIN	TYP	MAX	
t _{PL}	Z	А	Y	1.5V		11.5	15.4	ns

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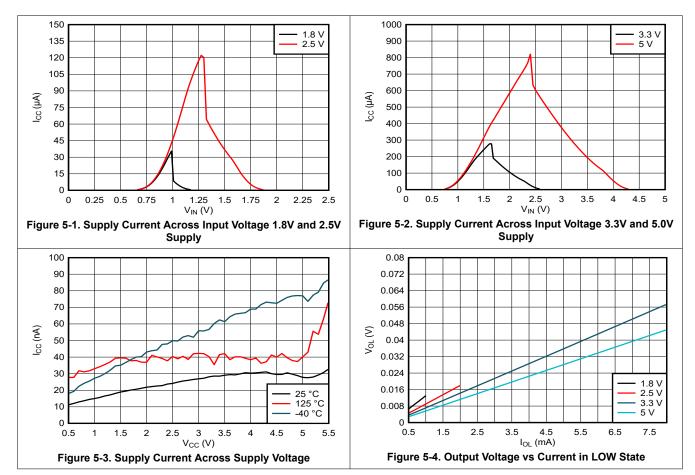


 C_L = 50 pF; over operating free-air temperature range; typical values measured at T_A = 25°C (unless otherwise noted). See *Parameter Measurement Information*.

PARAMETER			V	-40°C	UNIT		
PARAIVIETER	FROM (INPUT)	TO (OUTPUT)	V _{cc}	MIN	N TYP MAX	MAX	CIAIT
t _{PZL}	A	Y	1.5V		14.5	22.3	ns
t _{PLZ}	A	Y	1.8V		8.9	11.7	ns
t _{PZL}	A	Y	1.8V		10.9	16.3	ns
t _{PLZ}	A	Y	2.5V		4.4	6	ns
t _{PZL}	A	Y	2.5V		7.6	11.2	ns
t _{PLZ}	A	Y	3.3V		3.8	5.1	ns
t _{PZL}	A	Y	3.3V		6.3	9.2	ns
t _{PLZ}	A	Y	5V		2.6	3.6	ns
t _{PZL}	A	Y	5V		4.7	6.6	ns

5.7 Typical Characteristics

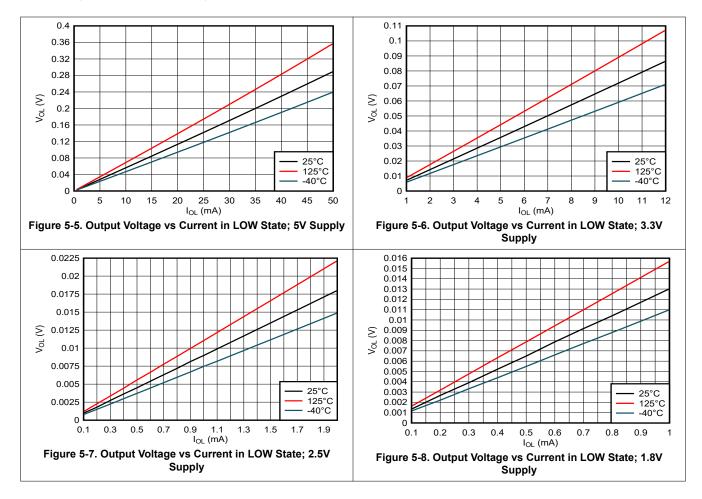
 $T_A = 25^{\circ}C$ (unless otherwise noted)





5.7 Typical Characteristics (continued)

T_A = 25°C (unless otherwise noted)

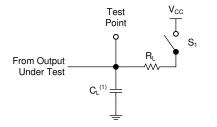


6 Parameter Measurement Information

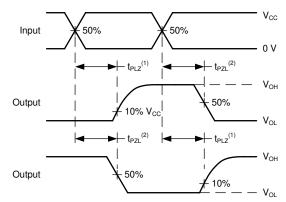
Phase relationships between waveforms were chosen arbitrarily for the examples listed in the following table. All input pulses are supplied by generators having the following characteristics: PRR \leq 1MHz, Z₀ = 50 Ω , t_t < 2.5ns.

The outputs are measured individually with one input transition per measurement.

TEST	S1	RL	CL	ΔV	V _{cc}
t _{PLZ} , t _{PZL}	CLOSED	1kΩ	50pF	0.15 V	≤ 2.5 V
t _{PLZ} , t _{PZL}	CLOSED	500Ω	50pF	0.3 V	> 2.5 V



(1) C_L includes probe and test-fixture capacitance. Figure 6-1. Load Circuit for Open-Drain Outputs



(1) t_{PLZ} is the same as t_{dis} .

(2) t_{PZL} is the same as $t_{\text{en}}.$

Figure 6-2. Voltage Waveforms Propagation Delays

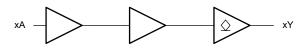


7 Detailed Description

7.1 Description

This device contains six independent buffers with open-drain outputs. Each gate performs the Boolean function Y = A in positive logic.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Open-Drain CMOS Outputs

This device includes open-drain CMOS outputs. Open-drain outputs can only drive the output low. When in the high logical state, open-drain outputs will be in a high-impedance state. The drive capability of this device may create fast edges into light loads, so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to overcurrent. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

When placed into the high-impedance state, the output will neither source nor sink current, with the exception of minor leakage current as defined in the *Electrical Characteristics* table. In the high-impedance state, the output voltage is not controlled by the device and is dependent on external factors. If no other drivers are connected to the node, then this is known as a floating node and the voltage is unknown. A pull-up resistor can be connected to the output to provide a known voltage at the output while it is in the high-impedance state. The value of the resistor will depend on multiple factors, including parasitic capacitance and power consumption limitations. Typically, a $10k\Omega$ resistor can be used to meet these requirements.

Unused open-drain CMOS outputs should be left disconnected.

7.3.2 Standard CMOS Inputs

This device includes standard CMOS inputs. Standard CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics*. The worst case resistance is calculated with the maximum input voltage, given in the *Absolute Maximum Ratings*, and the maximum input leakage current, given in the *Electrical Characteristics*, using Ohm's law ($R = V \div I$).

Standard CMOS inputs require that input signals transition between valid logic states quickly, as defined by the input transition time or rate in the *Recommended Operating Conditions* table. Failing to meet this specification will result in excessive power consumption and could cause oscillations. More details can be found in *Implications of Slow or Floating CMOS Inputs*.

Do not leave standard CMOS inputs floating at any time during operation. Unused inputs must be terminated at V_{CC} or GND. If a system will not be actively driving an input at all times, then a pull-up or pull-down resistor can be added to provide a valid input voltage during these times. The resistor value will depend on multiple factors; a $10k\Omega$ resistor, however, is recommended and will typically meet all requirements.

7.3.3 Wettable Flanks

This device includes wettable flanks for at least one package. See the *Features* section on the front page of the data sheet where packages include this feature.

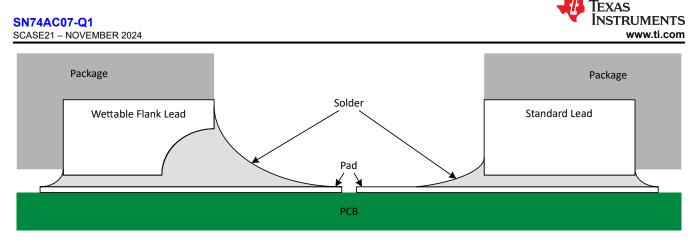


Figure 7-1. Simplified Cutaway View of Wettable-Flank QFN Package and Standard QFN Package After Soldering

Wettable flanks help improve side wetting after soldering, which makes QFN packages easier to inspect with automatic optical inspection (AOI). As shown in Figure 7-1, a wettable flank can be dimpled or step-cut to provide additional surface area for solder adhesion which assists in reliably creating a side fillet. See the mechanical drawing for additional details.

7.3.4 Clamp Diode Structure

The inputs to this device have both positive and negative clamping diodes, and the outputs to this device have negative clamping diodes only as depicted in Figure 7-2.

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

CAUTION

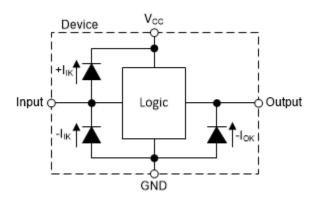


Figure 7-2. Electrical Placement of Clamping Diodes for Each Input and Output



7.4 Device Functional Modes

Table 7-1 lists the functional modes of the SN74AC07-Q1.

Table 7-1. Function Table

INPUTS ⁽¹⁾	OUTPUT ⁽²⁾
Α	Y
L	L
н	Z

- (1) H = High voltage level, L = Low voltage level
- (2) L = Driving low, Z = Highimpedance state



8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

Open-drain outputs like those available in the SN74AC07-Q1 provide the ability to discharge a voltage node to ground without otherwise loading the node significantly. It is recommended to add a series resistor between the output and any capacitance larger than 50pF as shown in the *Typical Application Block Diagram* to prevent damage to the device.

The required resistor value can be determined using the maximum capacitor voltage and the maximum continuous current for the output from the equation: $R \ge V_C/I_{O(max)}$.

For any given RC combination, the discharge time can be determined using the discharge plot provided in the *Application Timing Diagram* and the equation $\tau = R \times C$. For example, to discharge a capacitor to 10% of the starting value, it takes approximately $2.303 \times \tau = 2.303 \times R \times C$ seconds.

8.2 Typical Application

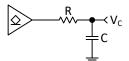


Figure 8-1. Typical Application Block Diagram



8.2.1 Design Requirements

8.2.1.1 Power Considerations

Ensure the desired supply voltage is within the range specified in the *Recommended Operating Conditions*. The supply voltage sets the device's electrical characteristics of the device as described in the *Electrical Characteristics* section.

The positive voltage supply must be capable of sourcing current equal to the maximum static supply current, I_{CC}, listed in the *Electrical Characteristics*, and any transient current required for switching.

The ground must be capable of sinking current equal to the total current to be sunk by all outputs of the SN74AC07-Q1 plus the maximum supply current, I_{CC} , listed in the *Electrical Characteristics*, and any transient current required for switching. The logic device can only sink as much current that can be sunk into its ground connection. Ensure the maximum total current through GND listed in the *Absolute Maximum Ratings* is not exceeded.

The SN74AC07-Q1 can drive a load with a total capacitance less than or equal to 50pF while still meeting all of the data sheet specifications. Larger capacitive loads can be applied; however, it is not recommended to exceed 50pF.

The SN74AC07-Q1 can drive a load with total resistance described by $R_L \ge V_O / I_O$, with the output voltage and current defined in the *Electrical Characteristics* table with V_{OL} . When outputting in the HIGH state, the output voltage in the equation is defined as the difference between the measured output voltage and the supply voltage at the V_{CC} pin.

Total power consumption can be calculated using the information provided in *CMOS Power Consumption and Cpd Calculation*.

Thermal increase can be calculated using the information provided in *Thermal Characteristics of Standard Linear and Logic (SLL) Packages and Devices.*

CAUTION

The maximum junction temperature, $T_{J(max)}$ listed in the *Absolute Maximum Ratings*, is an additional limitation to prevent damage to the device. Do not violate any values listed in the *Absolute Maximum Ratings*. These limits are provided to prevent damage to the device.



8.2.1.2 Input Considerations

Input signals must cross $V_{IL(max)}$ to be considered a logic LOW, and $V_{IH(min)}$ to be considered a logic HIGH. Do not exceed the maximum input voltage range found in the *Absolute Maximum Ratings*.

Unused inputs must be terminated to either V_{CC} or ground. The unused inputs can be directly terminated if the input is completely unused, or they can be connected with a pull-up or pull-down resistor if the input will be used sometimes, but not always. A pull-up resistor is used for a default state of HIGH, and a pull-down resistor is used for a default state of LOW. The drive current of the controller, leakage current into the SN74AC07-Q1 (as specified in the *Electrical Characteristics*), and the desired input transition rate limits the resistor size. A 10k Ω resistor value is often used due to these factors.

The SN74AC07-Q1 has CMOS inputs and thus requires fast input transitions to operate correctly, as defined in the *Recommended Operating Conditions* table. Slow input transitions can cause oscillations, additional power consumption, and reduction in device reliability.

Refer to the *Feature Description* section for additional information regarding the inputs for this device.

8.2.1.3 Output Considerations

The ground voltage is used to produce the output LOW voltage. Sinking current into the output will increase the output voltage as specified by the V_{OL} specification in the *Electrical Characteristics*.

Open-drain outputs can be connected together directly to produce a wired-AND configuration or for additional output drive strength.

Unused outputs can be left floating. Do not connect outputs directly to V_{CC} or ground.

Refer to the *Feature Description* section for additional information regarding the outputs for this device.



8.2.2 Detailed Design Procedure

- Add a decoupling capacitor from V_{CC} to GND. The capacitor needs to be placed physically close to the device and electrically close to both the V_{CC} and GND pins. An example layout is shown in the *Layout* section.
- Ensure the capacitive load at the output is ≤ 50pF. This is not a hard limit; by design, however, it will
 optimize performance. This can be accomplished by providing short, appropriately sized traces from the
 SN74AC07-Q1 to one or more of the receiving devices.
- Ensure the resistive load at the output is larger than (V_{CC} / I_{O(max)})Ω. Doing this will prevent the maximum output current from the *Absolute Maximum Ratings* from being violated. Most CMOS inputs have a resistive load measured in MΩ; much larger than the minimum calculated previously.
- 4. Thermal issues are rarely a concern for logic gates; the power consumption and thermal increase, however, can be calculated using the steps provided in the application report, *CMOS Power Consumption and Cpd Calculation*.

8.2.3 Application Curves

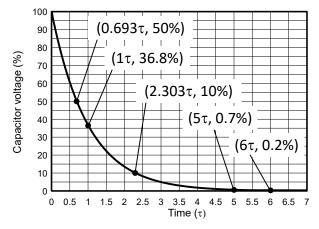


Figure 8-2. Application Timing Diagram

8.3 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A 0.1µF capacitor is recommended for this device. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. The 0.1µF and 1µF capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

8.4 Layout

8.4.1 Layout Guidelines

- · Bypass capacitor placement
 - Place near the positive supply terminal of the device
 - Provide an electrically short ground return path
 - Use wide traces to minimize impedance
 - Keep the device, capacitors, and traces on the same side of the board whenever possible
- Signal trace geometry
 - 8mil to 12mil trace width
 - Lengths less than 12cm to minimize transmission line effects
 - Avoid 90° corners for signal traces
 - Use an unbroken ground plane below signal traces
 - Flood fill areas around signal traces
 - For traces longer than 12cm
 - Use impedance controlled traces



- Source-terminate using a series damping resistor near the output
- Avoid branches; buffer signals that must branch separately

8.4.2 Layout Example

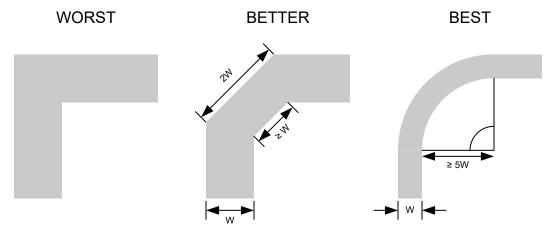
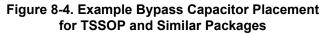


Figure 8-3. Example Trace Corners for Improved Signal Integrity

GND 0.1	V _{cc} µF
<u> </u>	13
3	12
4	11
5	10
6	9
GND 7	8



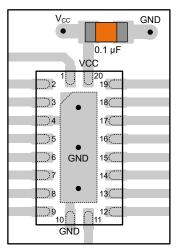


Figure 8-5. Example Bypass Capacitor Placement for WQFN and Similar Packages

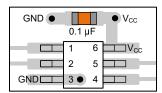


Figure 8-6. Example Bypass Capacitor Placement for SOT, SC70 and Similar Packages

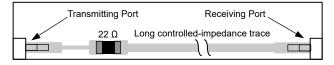


Figure 8-7. Example Damping Resistor Placement for Improved Signal Integrity



9 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

9.1 Documentation Support

9.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, *CMOS Power Consumption and C_{pd} Calculation* application report
- Texas Instruments, Designing With Logic application report
- Texas Instruments, *Thermal Characteristics of Standard Linear and Logic (SLL) Packages and Devices* application report

9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

9.4 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

9.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
November 2024	*	Initial release

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74AC07PWRQ1	ACTIVE	TSSOP	PW	14	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AC07Q	Samples
SN74AC07WBQARQ1	ACTIVE	WQFN	BQA	14	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AC07Q	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN74AC07-Q1 :

Catalog : SN74AC07

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product



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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	-	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AC07PWRQ1	TSSOP	PW	14	3000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AC07WBQARQ1	WQFN	BQA	14	3000	180.0	12.4	2.8	3.3	1.1	4.0	12.0	Q1



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PACKAGE MATERIALS INFORMATION

23-Nov-2024



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AC07PWRQ1	TSSOP	PW	14	3000	353.0	353.0	32.0
SN74AC07WBQARQ1	WQFN	BQA	14	3000	210.0	185.0	35.0

PW0014A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



PW0014A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0014A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



BQA 14

2.5 x 3, 0.5 mm pitch

GENERIC PACKAGE VIEW

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





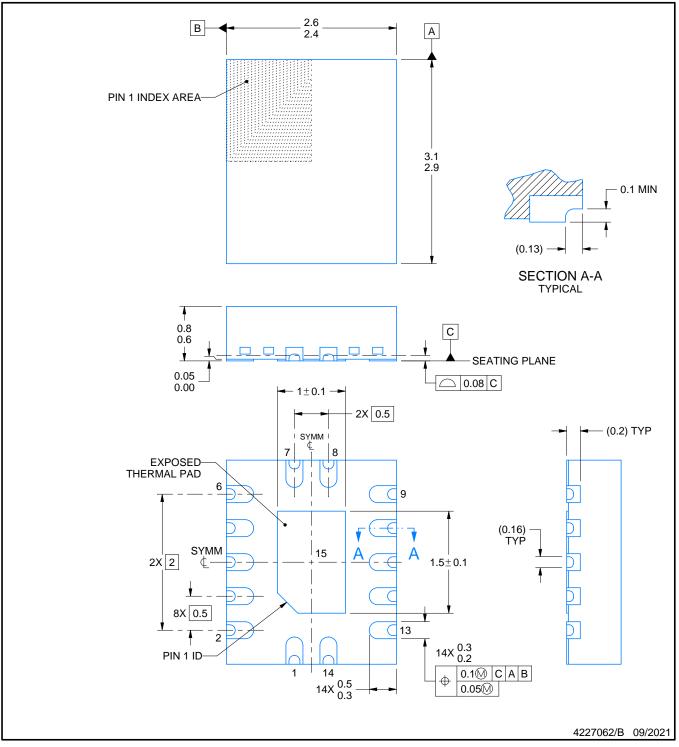
BQA0014B



PACKAGE OUTLINE

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

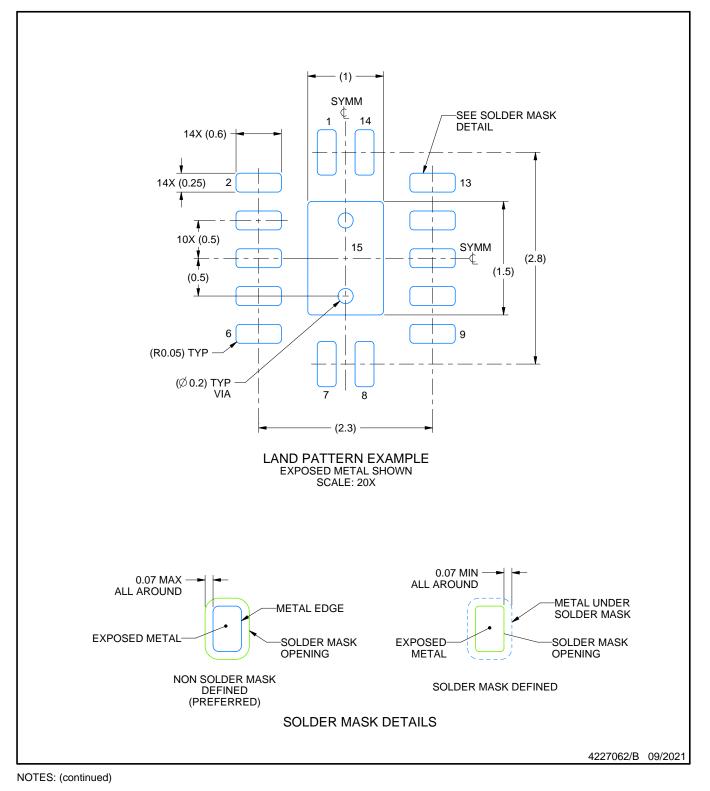


BQA0014B

EXAMPLE BOARD LAYOUT

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

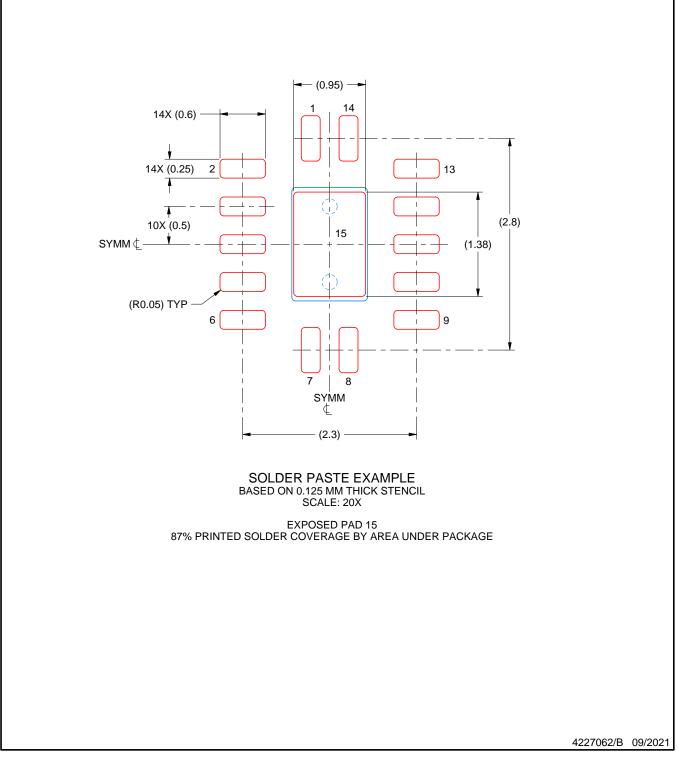


BQA0014B

EXAMPLE STENCIL DESIGN

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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